QPD1026L

1300 W, 65 V, 420 – 450 MHz, GaN RF Input-Matched Transistor

Product Overview

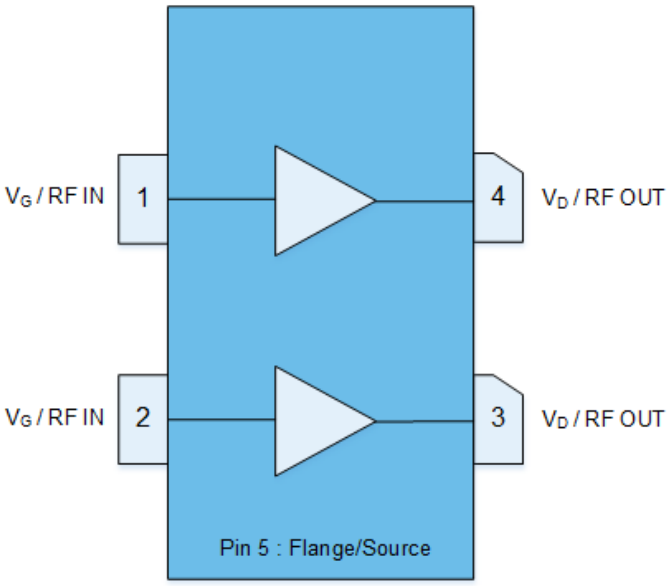
The Qorvo QPD1026L is a 1300 W (P_{3dB}) discrete GaN on SiC HEMT which operates from 420 to 450 MHz. Input pre-match within the package results in ease of external board match and saves board space. The device is in an industry standard air cavity package and is ideally suited for amateur radio, public safety radio and radiolocation service. The device can support both CW and pulsed operations.

RoHS compliant

Evaluation boards are available upon request.

4-lead NI-1230 Package (Eared)

Functional Block Diagram



Key Features

- Frequency: 420 to 450 MHz
- Output Power (P_{3dB})[1]: 1318 W
- Linear Gain[1]: 25.9 dB
- Typical PAE_{3dB}[1]: 80.8 %
- Operating Voltage: 65 V
- CW and Pulse capable

Note 1: @ 440 MHz Load Pull

Applications

- UHF Radar
- Amateur Radio
- Public Safety Radio
- Radiolocation Service

Ordering Information

Part No.	Description
QPD1026L	420 – 450 MHz Transistor
QPD1026LEVB1	432 – 460 MHz Evaluation Board

Absolute Maximum Ratings [1, 2, 3]

Parameter	Rating	Units
Breakdown Voltage, BV_{DG}	225	V
Gate Voltage Range, V_G	-7 to +2	V
Drain Current, I_{DMAX}	142	A
Gate Current Range, I_G	See pg. 4	mA
Power Dissipation, Pulsed, P_{DISS} [2]	1000	W
RF Input Power, Pulsed, P_{IN} [3]	43.2	dBm
Mounting Temperature (30 Seconds)	320	°C
Storage Temperature	−65 to +150	°C

Notes:
1. Operation of this device outside the parameter ranges given above may cause permanent damage
2. Pulsed, 500us PW, 5% DC, Package base at 85 °C
3. Pulsed, 500us PW, 5% DC, T = 25 °C

Recommended Operating Conditions [1, 2, 3, 4]

Parameter	Min	Typ	Max	Units
Operating Temp. Range	−40	+25	+85	°C
Drain Voltage Range, V_D	–	+65	+70	V
Drain Bias Current, I_{DQ}		1.5		A
Drain Current, I_D [4]	–	28	–	A
Gate Voltage, V_G [3]	–	−2.8	–	V
Power Dissipation (P_D) [2,4]	–	–	907	W
Power Dissipation (P_D), CW [2]	–	–	510	W

Notes:
1. Electrical performance is measured under conditions noted in the electrical specifications table. Specifications are not guaranteed over all recommended operating conditions
2. Package base at 85 °C
3. To be adjusted to desired I_{DQ}
4. Pulsed, 500us PW, 5% DC

Measured Load Pull Performance – 65V Power Tuned [1, 2]

Parameter	Typical Values				Units
Frequency, F	420	430	440	450	MHz
Output Power at 3dB compression, P_{3dB}	59.3	59.2	59.2	59.1	dBm
Power Added Efficiency at 3dB compression, PAE_{3dB}	59.1	60.0	64.5	69.0	%
Gain at 3dB compression, G_{3dB}	23.7	24.6	23.8	24.6	dB

Notes:
1. Test conditions unless otherwise noted: T_A = 25 °C, V_D = 65 V, I_{DQ} = 750 mA (half device)
2. Pulsed, 500 us Pulse Width, 5% Duty Cycle.

Measured Load Pull Performance – 65V Efficiency Tuned [1, 2]

Parameter	Typical Values				Units
Frequency, F	420	430	440	450	MHz
Output Power at 3dB compression, P_{3dB}	56.7	56.4	57.5	57.3	dBm
Power Added Efficiency at 3dB compression, PAE_{3dB}	78.9	79.7	80.8	80.6	%
Gain at 3dB compression, G_{3dB}	27.5	26.4	25.9	26.3	dB

Notes:
1. Test conditions unless otherwise noted: T_A = 25 °C, V_D = 65 V, I_{DQ} = 750 mA (half device)
2. Pulsed, 500 us Pulse Width, 5% Duty Cycle.

RF Characterization – 432 – 460 MHz EVB Performance at 442 MHz [1]

Parameter	Min	Typ	Max	Units
Linear Gain, G_{LIN}	–	23.6	–	dB
Output Power at 3dB compression point, P3dB	–	1114	–	W
Drain Efficiency at 3dB compression point, DEFF3dB	–	81.6	–	%
Gain at 3dB compression point, G3dB	–	20.6	–	dB

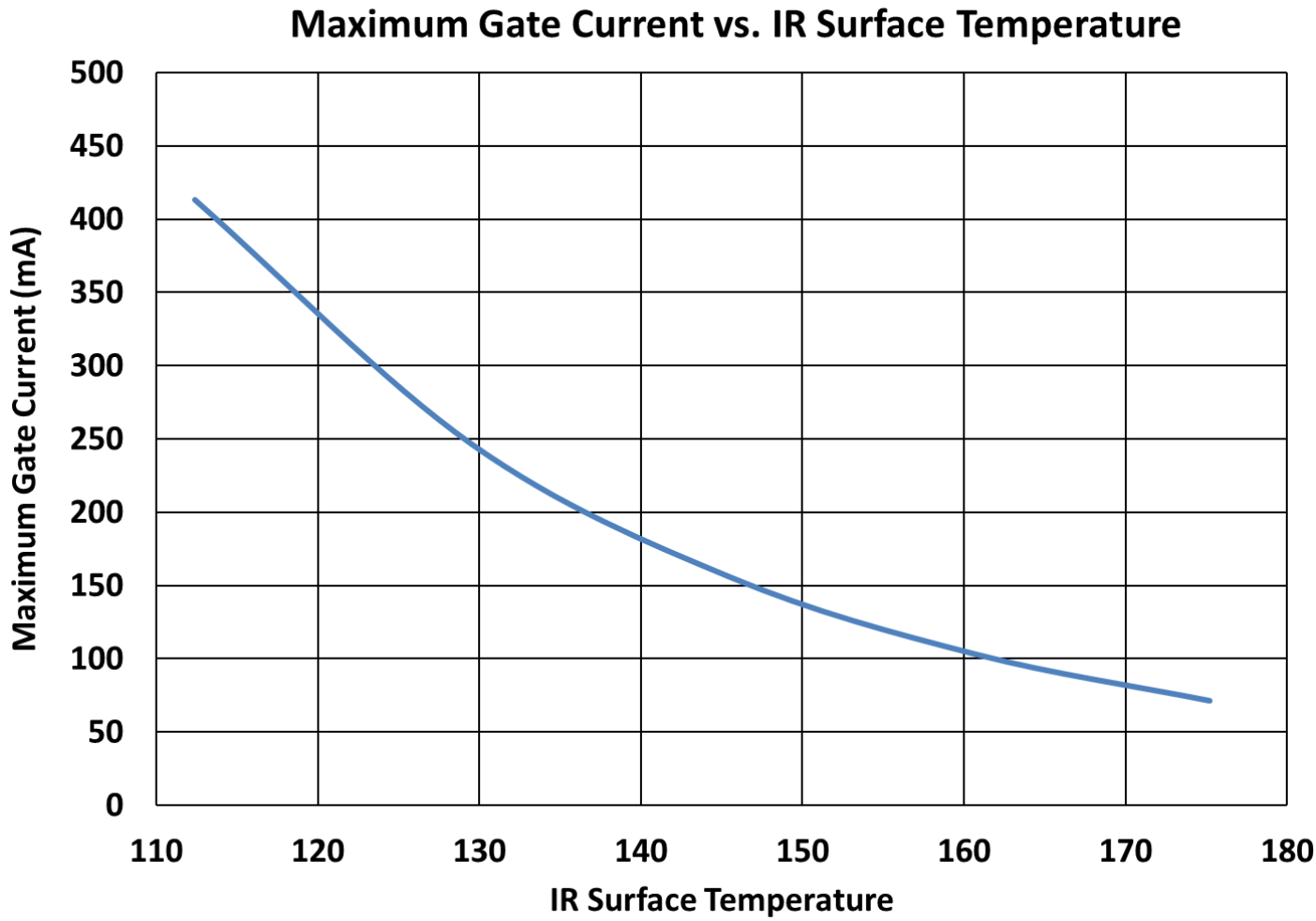
Notes:
1. V_D = 65 V, I_{DQ} = 1.5 A (combined), Temp = +25 °C, Pulse Width = 500 us, Duty Cycle = 5%

RF Characterization – Mismatch Ruggedness at 442 MHz [1, 2, 3]

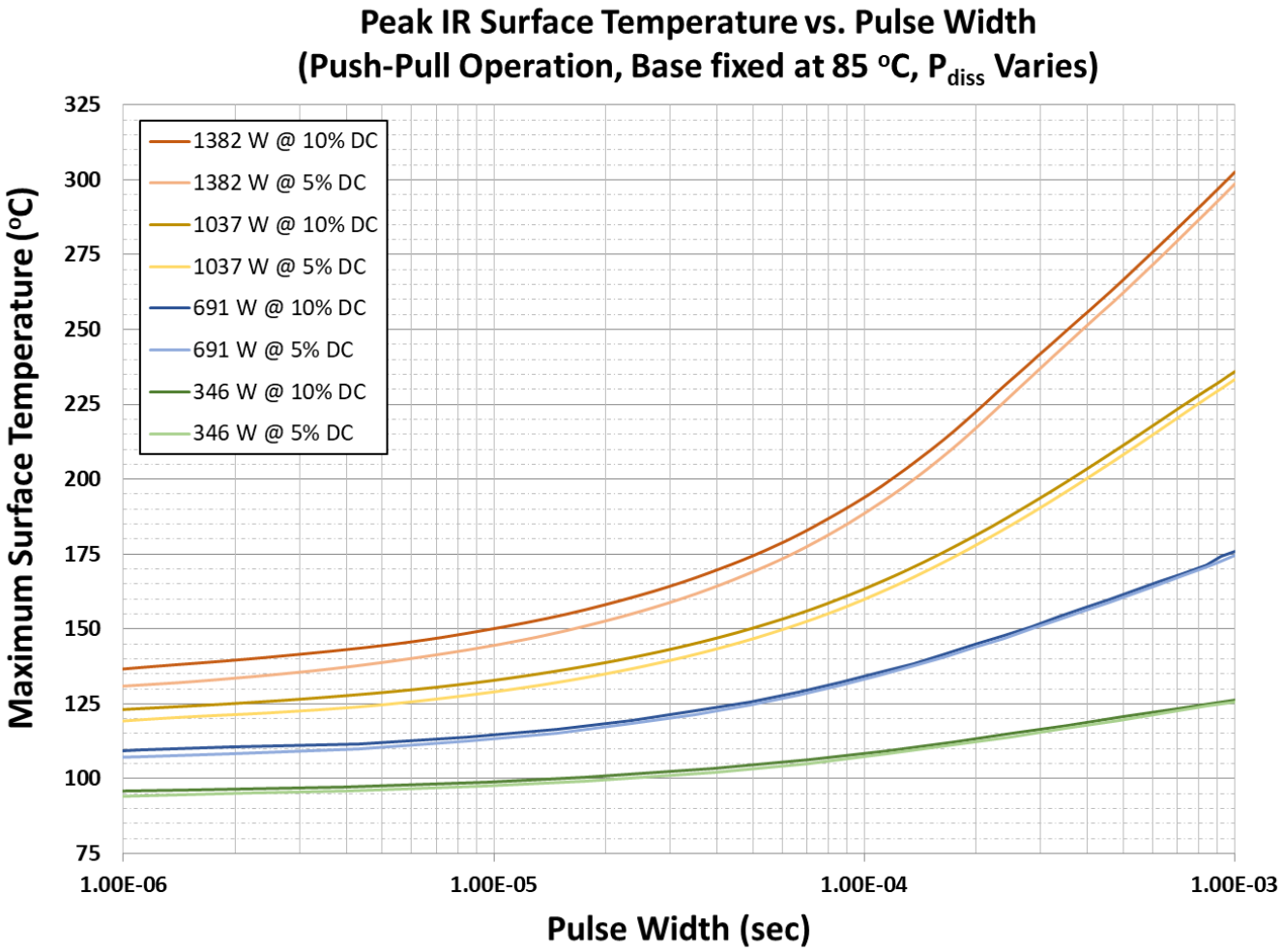
Symbol	Parameter	dB Compression	Typical
VSWR	Impedance Mismatch Ruggedness	3	6:1

Notes:
1. Test conditions unless otherwise noted: T_A = 25 °C, V_D = 65 V, I_{DQ} = 1.5 A (combined)
2. Input drive power is determined at pulsed 3dB compression under matched condition at EVB output connector
3. Pulse: 500us, 5% Duty cycle

Maximum Gate Current



Thermal and Reliability Information [1]

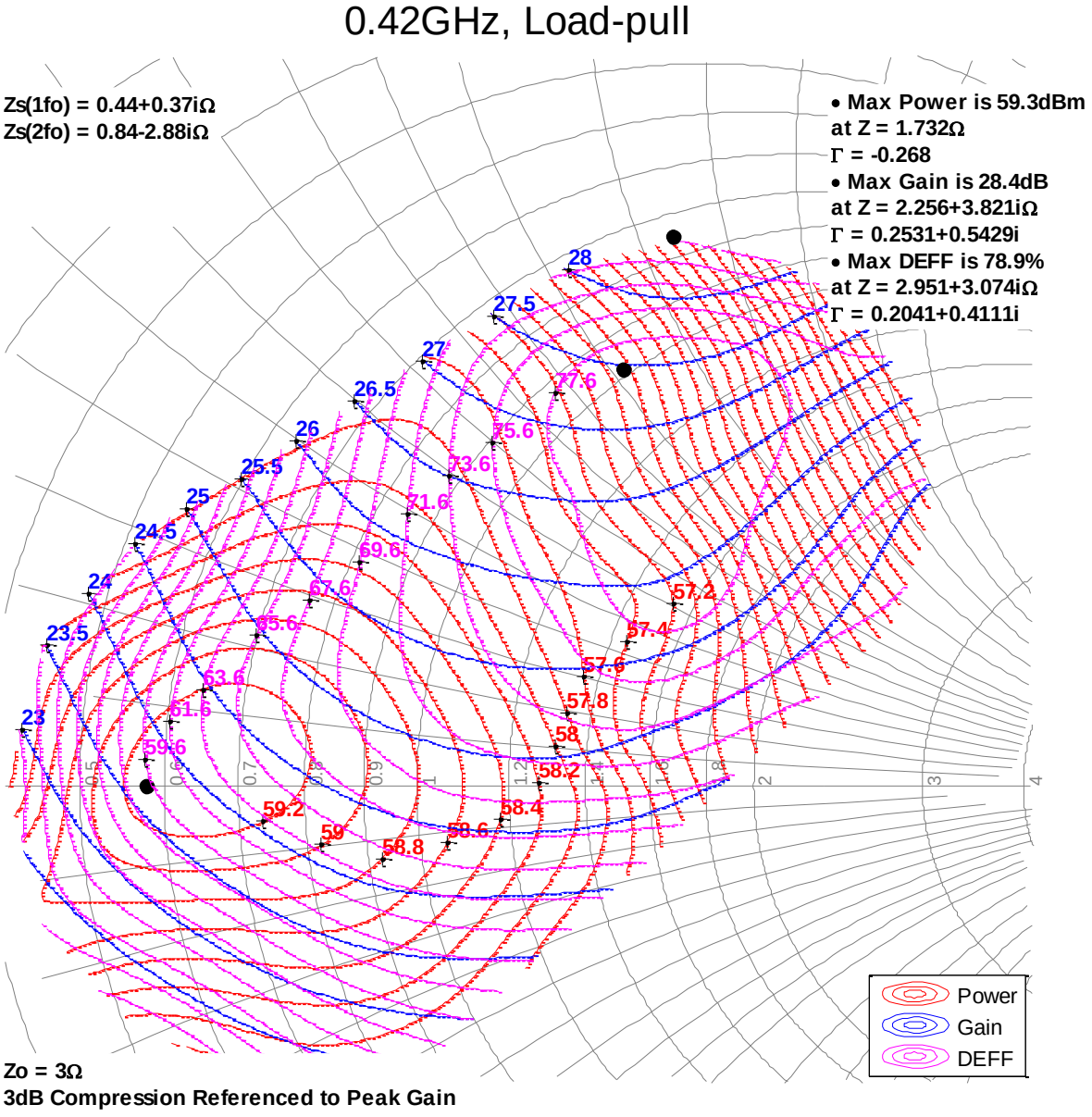


Parameter	Conditions	Values	Units
Thermal Resistance, IR[1] (θ_{JC})	85 °C Case backside Temperature Pdiss = 346 W, Pulse: 500 us PW, 5% DC	0.10	°C/W
Peak IR Surface Temperature[1] (T_{ch})		120	°C

Note:
1. Refer to the following document GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates

Measured Load-Pull Smith Charts at 65V [1, 2, 3]

Notes:
1. Test Conditions: V_D = 65 V, I_{DQ} = 750 mA, 500 us Pulse Width, 5% Duty Cycle, Temp = 25°C.
2. The performance shown below is for only half of the device out of the two independent amplification paths.
3. See *"Pin Configuration and Description"* for load pull reference planes where the performance was measured.



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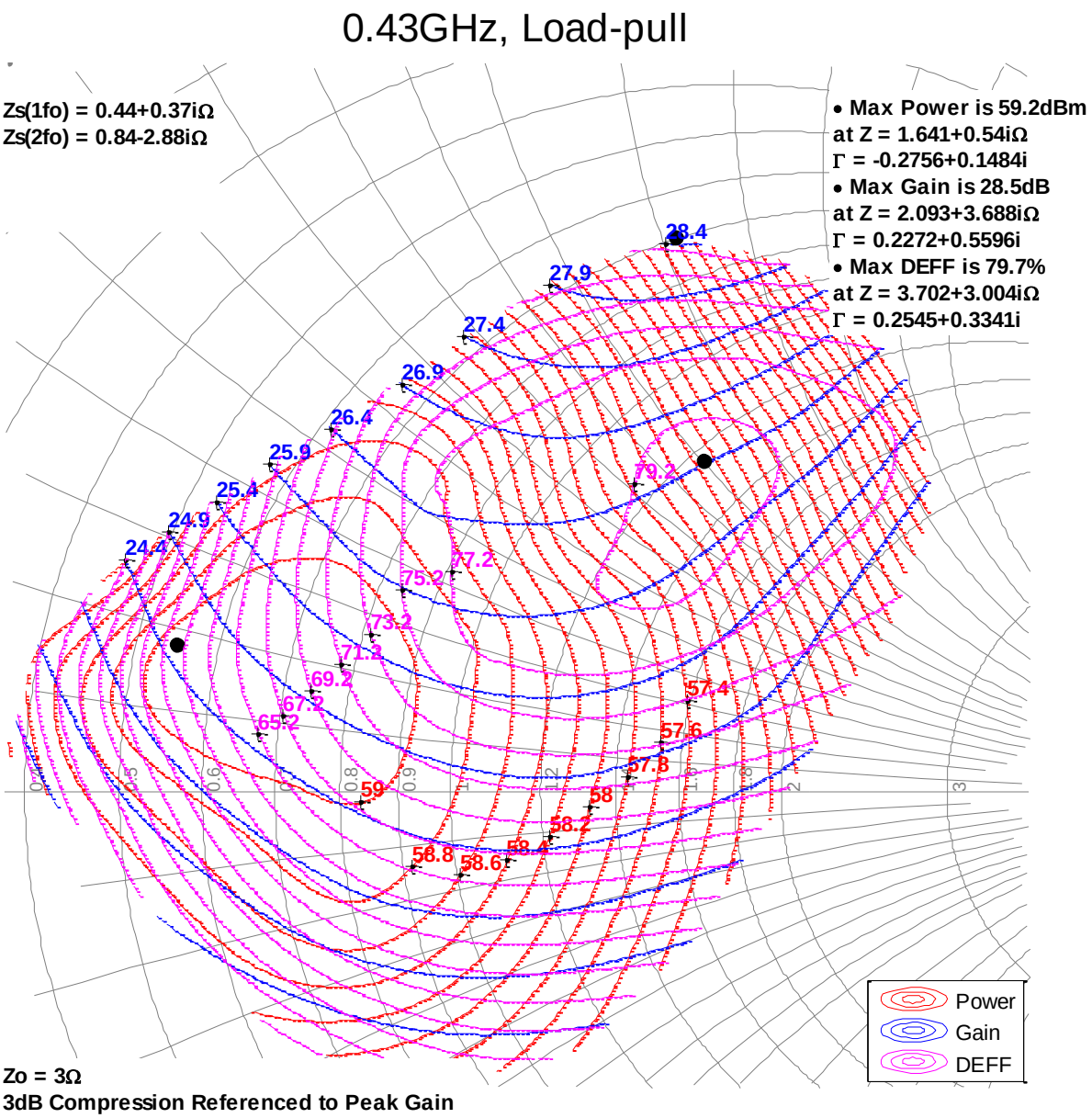

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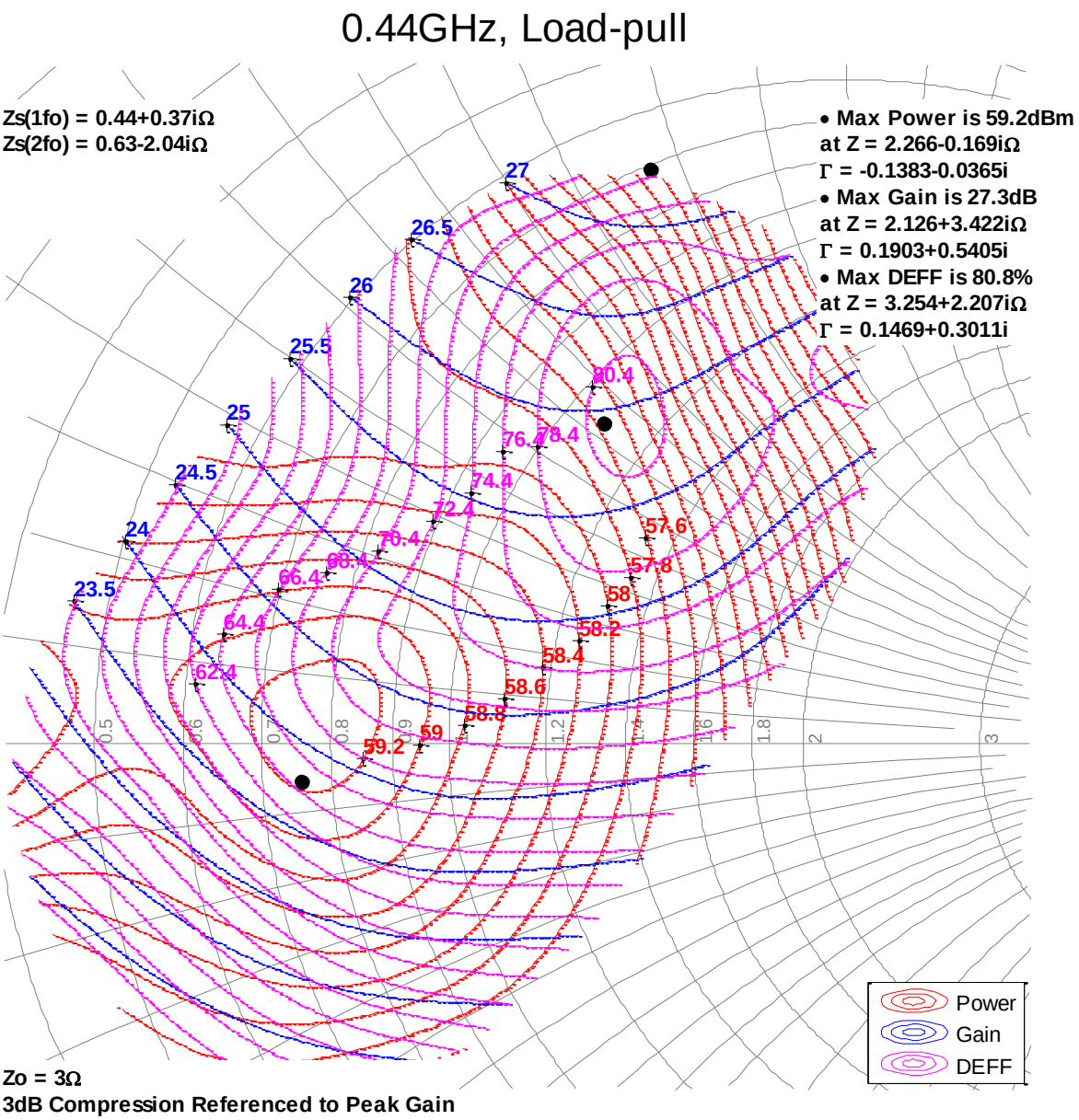

Measured Load-Pull Smith Charts at 65V [1, 2, 3]

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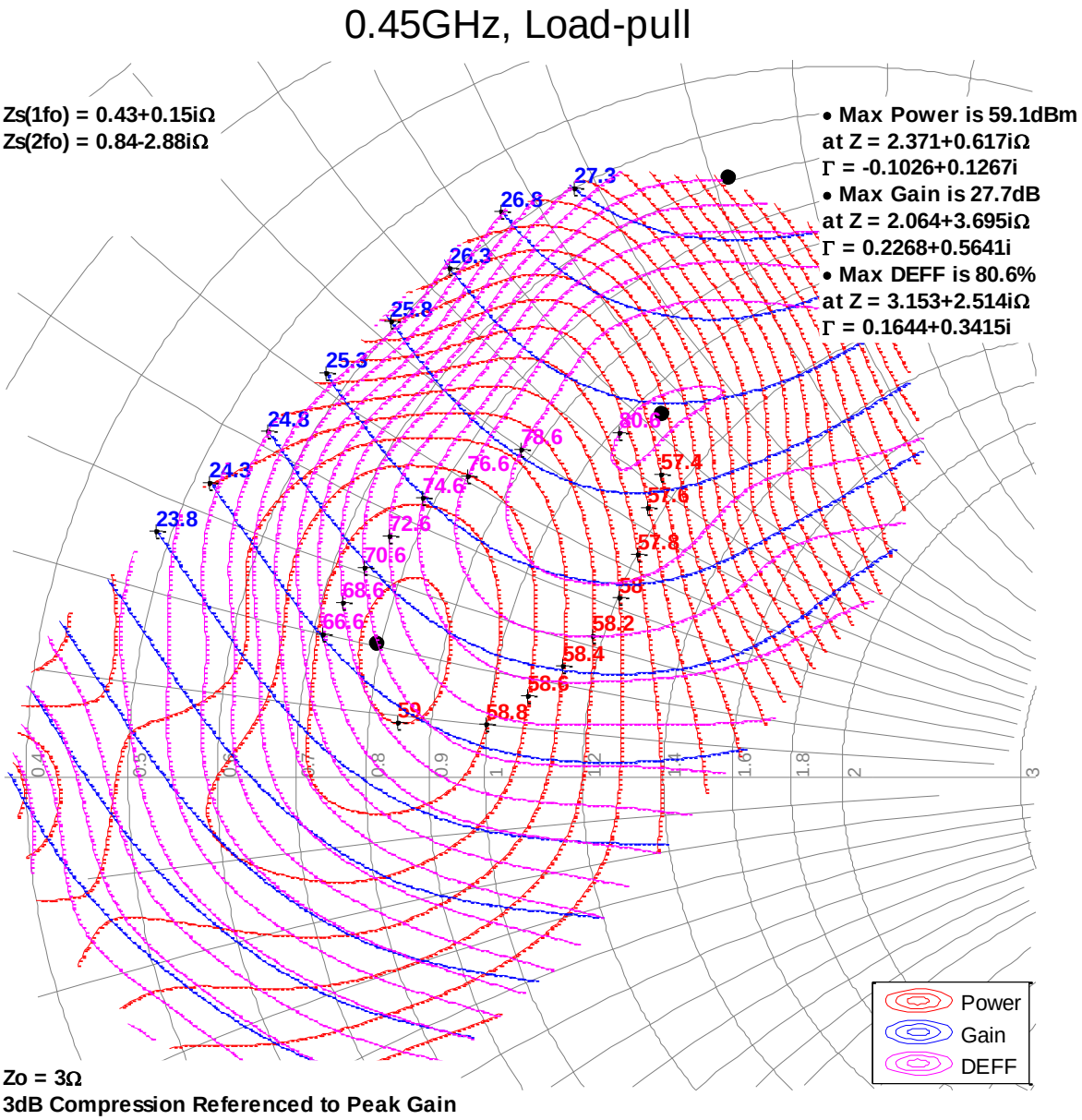

Typical Measured Performance – Load-Pull Drive-up at 65V [1, 2, 3]

Notes:
1. Test Conditions: V_D = 65 V, I_{DQ} = 750 mA, 500 us Pulse Width, 5% Duty Cycle, Temp = 25°C.
2. The performance shown below is for only half of the device out of the two independent amplification paths.
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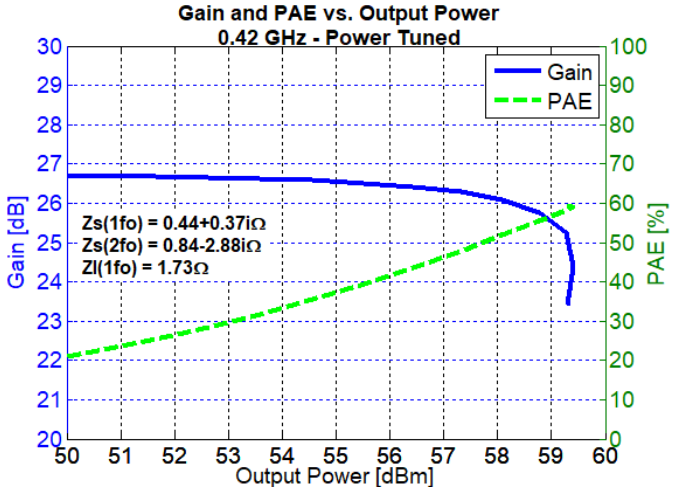

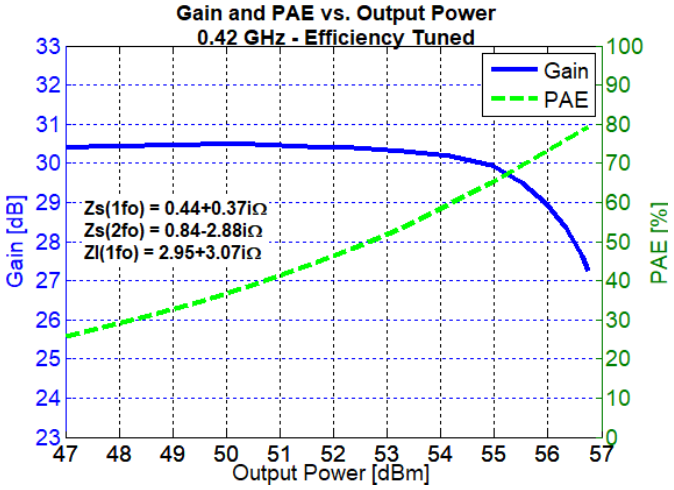

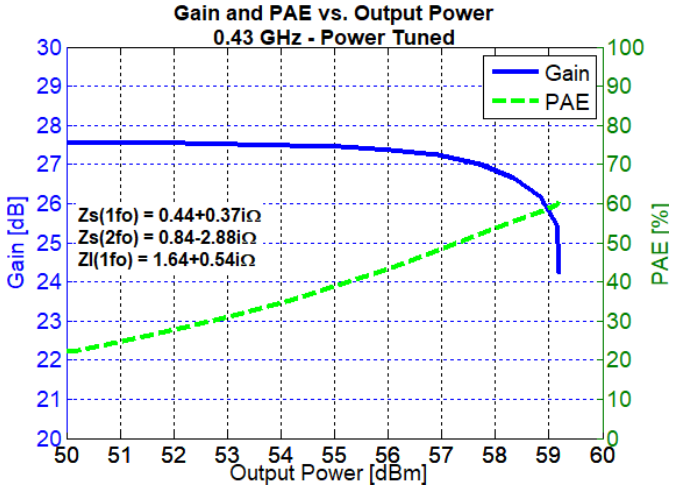

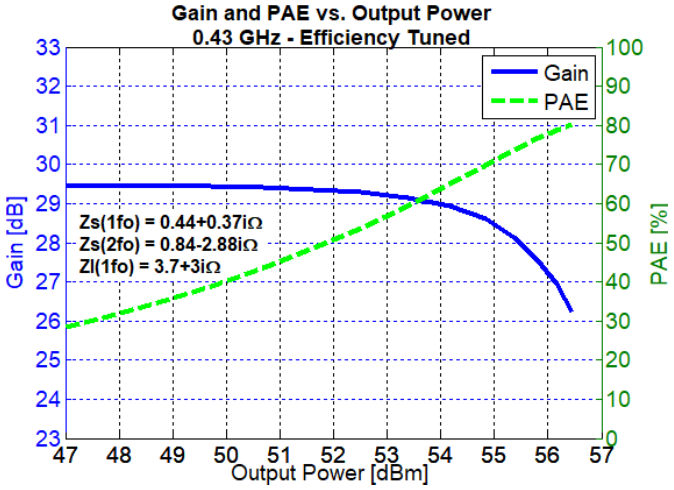

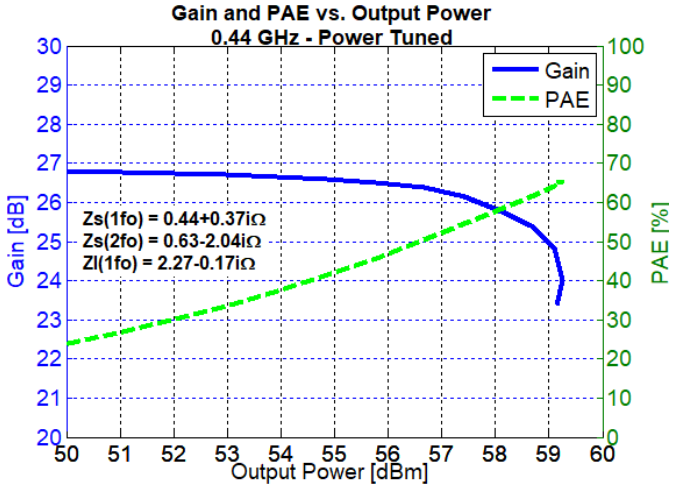

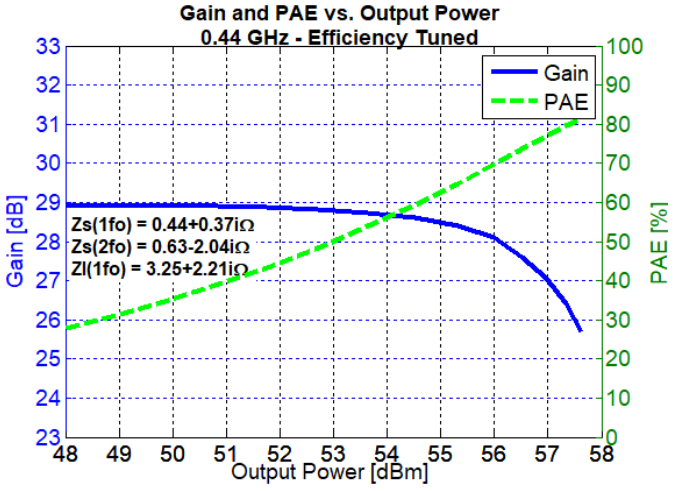

Typical Measured Performance – Load-Pull Drive-up at 65V [1, 2, 3]

Notes:
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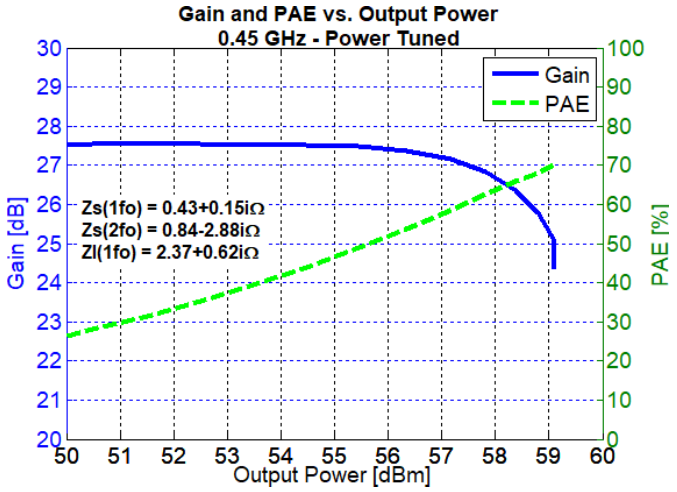
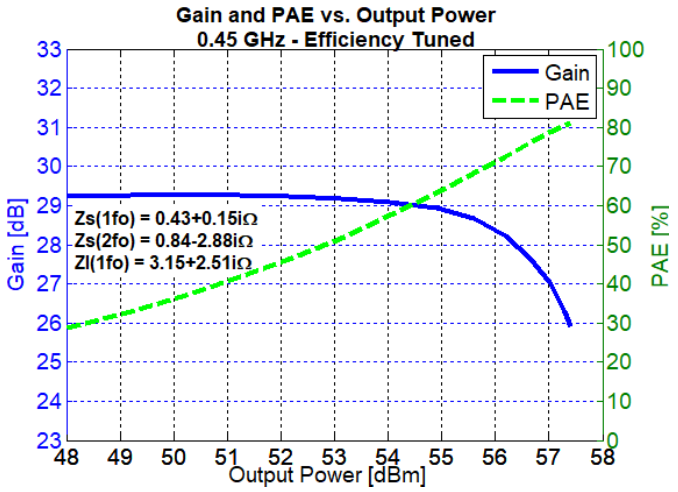
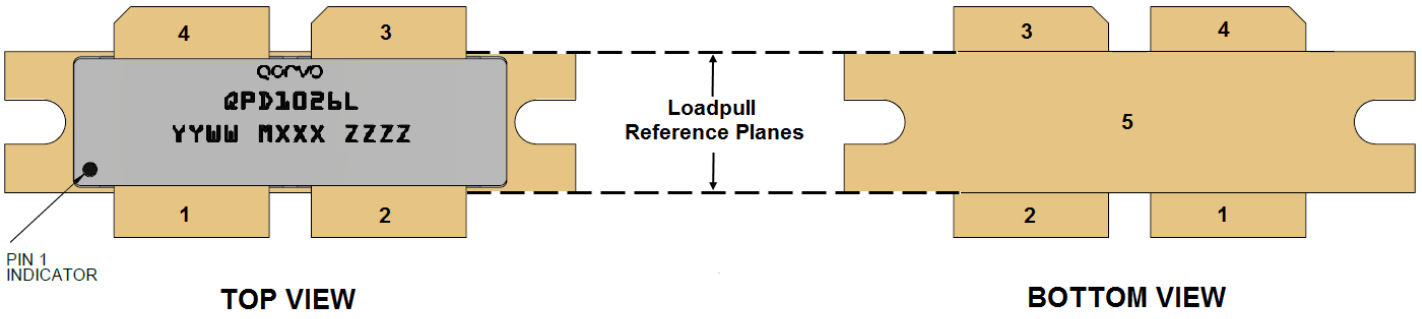
2. The performance shown below is for only half of the device out of the two independent amplification paths.
3. See *"Pin Configuration and Description"* for load pull reference planes where the performance was measured.





Pin Configuration and Description [1]



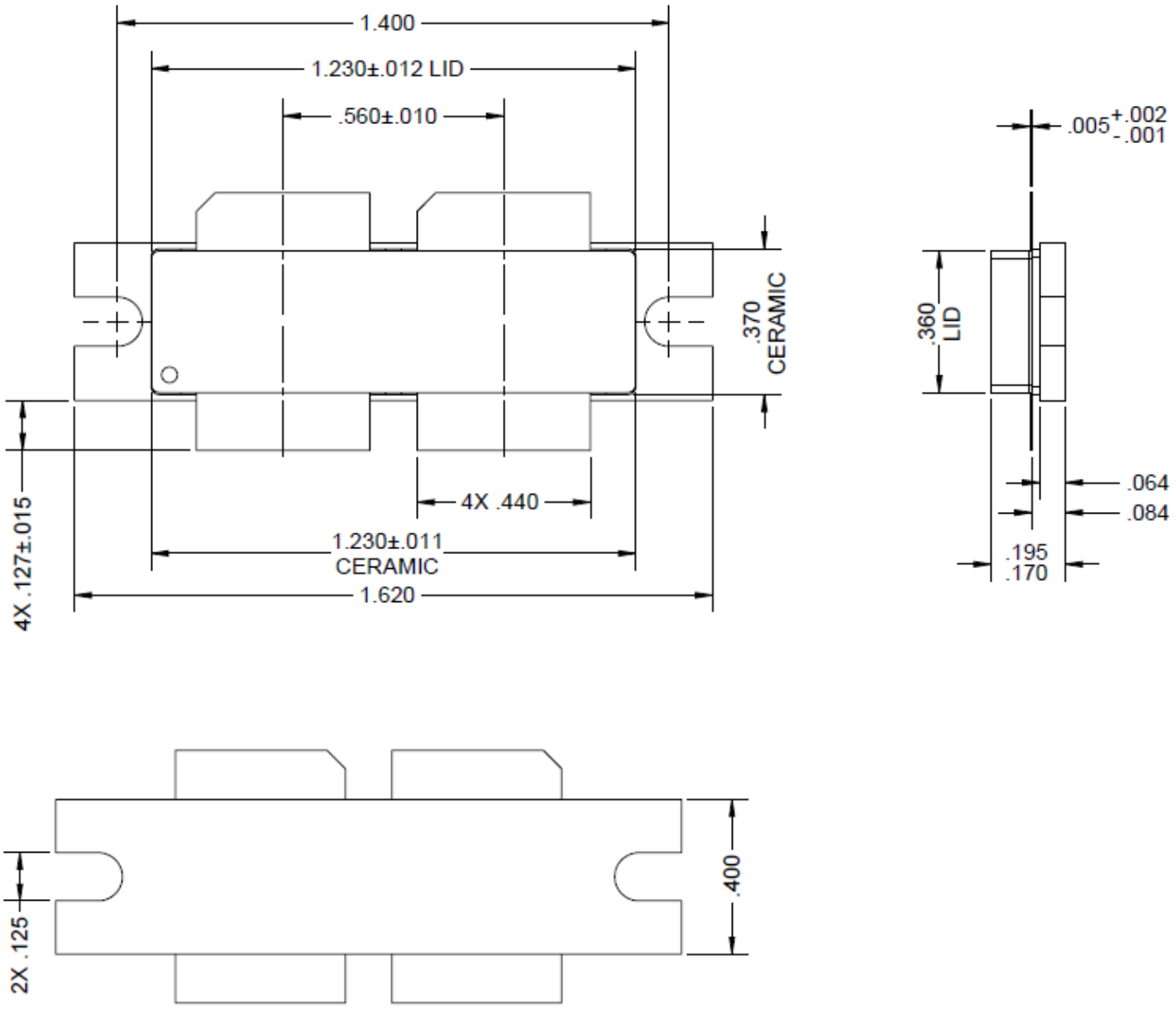
Note:

1. The QPD1026L will be marked with the “QPD1026L” designator and a lot code marked below the part designator. The “YY” represents the last two digits of the calendar year the part was manufactured, the “WW” is the work week of the assembly lot start, the “MXXX” is the production lot number, and the “ZZZ” is an auto-generated serial number.

Pin Description

Pin	Symbol	Description
1, 2	RF IN / V_G	Gate
3, 4	RF OUT / V_D	Drain
5	Source	Source / Ground / Backside of part

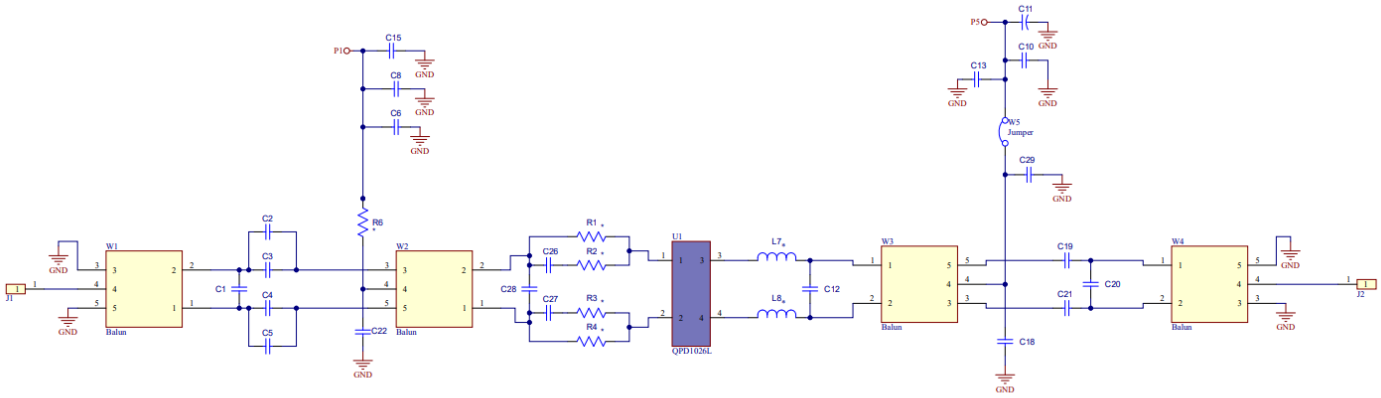
Mechanical Drawing (NI-1230)[1-7]



Notes:

1. All dimensions are in inches.
2. Dimension tolerance is ± 0.005 inches, unless noted otherwise.
3. Package base: Ceramic/Metal, Package lid: Ceramic
4. Package Metal base and leads are gold plated
5. Parts are epoxy sealed.
6. Parts meet industry standard NI1230 footprint
7. Body dimensions do not include runout which can be up to 0.020 inches per side.

432 – 460 MHz Application Circuit - Schematic

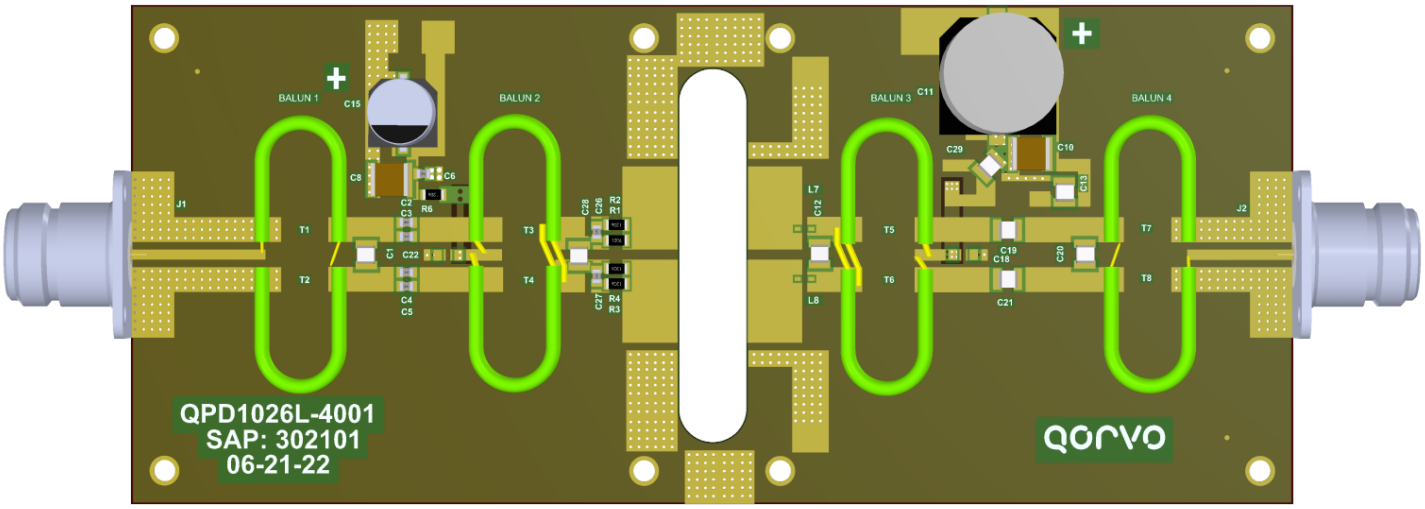


Bias-up Procedure	Bias-down Procedure
1. Set V_G to -5 V.	1. Turn off RF signal.
2. Set I_D current limit to 4 A.	2. Turn off V_D
3. Apply 65 V V_D.	3. Wait 2 seconds to allow drain capacitor to discharge.
4. Slowly adjust V_G until I_D is set to 1.5 A.	4. Turn off V_G
5. Apply RF.	

432 – 460 MHz Application Circuit EVB – Layout [1]

Notes:

1. PCB material is RO4350B 0.030” thick, 2 oz. copper each side.

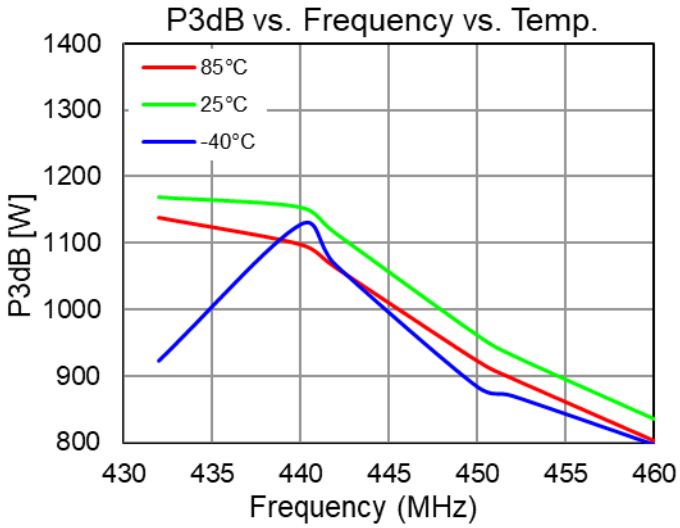


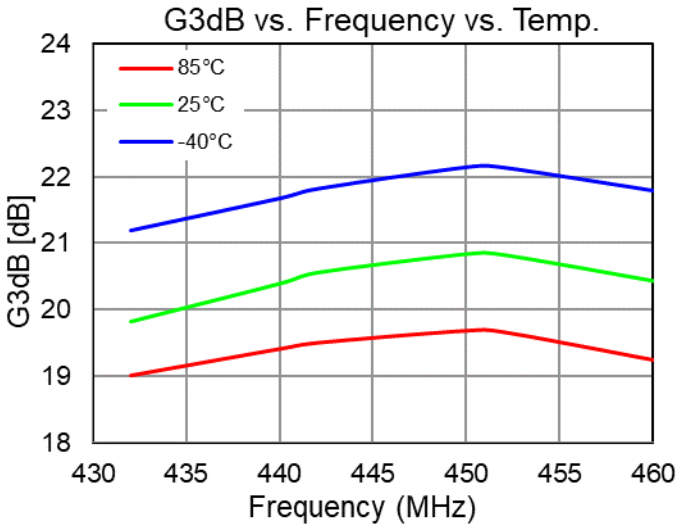
432 – 460 MHz Application Circuit Bill of Material

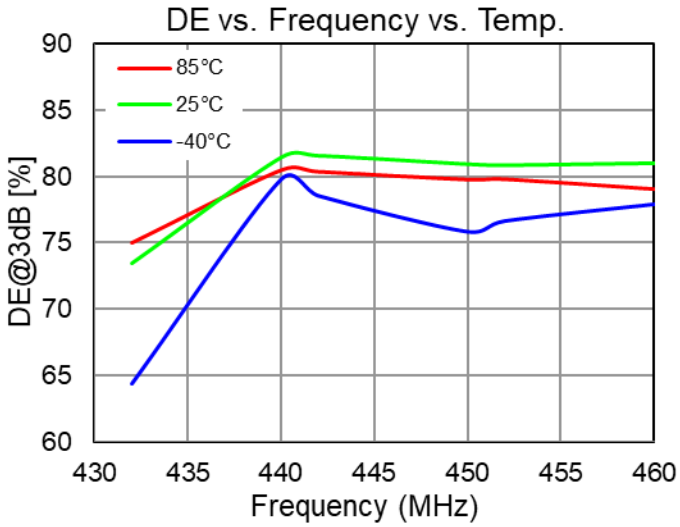
Reference Design	Value	Qty	Description	Manf. Part Number
Balun 1	50 Ohm	1	Semi-rigid coax, 1.7" shield length	UT-085-50
Balun 2	25 Ohm	1	Semi-rigid coax, 1.7" shield length	UT-090-25
Balun 3	25 Ohm	1	Semi-rigid coax, 1.7" shield length	UT-090-25
Balun 4	50 Ohm	1	Semi-rigid coax, 1.7" shield length	UT-085-50
C1, C20	8.2 pF	2	CAP, 800B, 500V, C0G	800B8R2CT500XT
C2, C3, C4, C5	4.7 pF	4	CAP, 600F, 250V, 0805	600F4R7BT250XT
C6	100 pF	1	CAP, 600F, 250V, C0G	600F101JT250XT
C8	10 uF	1	CAP, 10µF, 10%, 50V, X7S, 2220	C5750X7R1H106K230KB
C10	10 uF	1	CAP, 10uF, 20%, 100V, X7R, 2220	22201C106MAT2A
C11	680 uF	1	CAP, 20%, 80V, Aluminum Electrolytic	MAL215099708E3
C12	22 pF	1	22pF, 800B, 500V, C0G	ATC800B220JW500XT
C13, C29	560 pF	2	560pF, 800B, 500V, C0G	ATC800B561JW100XT
C15	220 uF	1	CAP, 20%, 50V, Aluminum Electrolytic	EMVY500ADA221MJA0G
C19, C21	220 pF	2	220pF, 800B, 500V, C0G	ATC800B221JW200XT
C18, C22	560 pF	2	560pF 800B, vertical placement	ATC800B561JW100XT
C26, C27	56 pF	2	CAP, 56pF, 5%, 250V, C0G, 0805	600F560JT250XT
C28	15 pF	1	CAP, 15pF, 5%, 500V, C0G, ATC-B	800B150JT500XT
R1, R4	5.1 Ohm	2	RES, 5.1 OHM, 1%, 1/4W, SMT, 1206	CRCW12065R10FKEA
R2, R3	0.5 Ohm	2	0.5 ohm, 1%, 1/2W 1206	CSR1206FTR500
R6	10 Ohm	1	RES, 10 OHM, 1%, 1/4W, SMT, 1206	CRCW120610R0FKEA
L7, L8	–	2	18 AWG wire, 6 mm long bent at 3 mm	–

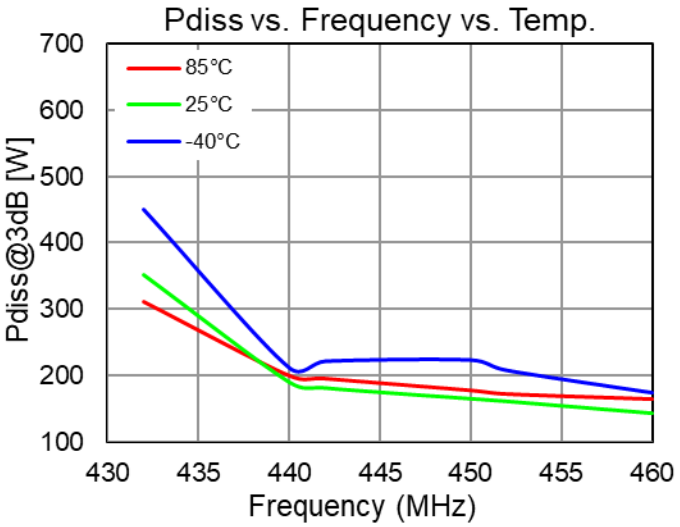
Power Driveup Performance over Temperatures of 432 – 460 MHz EVB [1]

Notes:
1. Test Conditions: V_D = 65 V, I_{DQ} = 1.5 A, 500 us Pulse Width, 5% Duty Cycle.



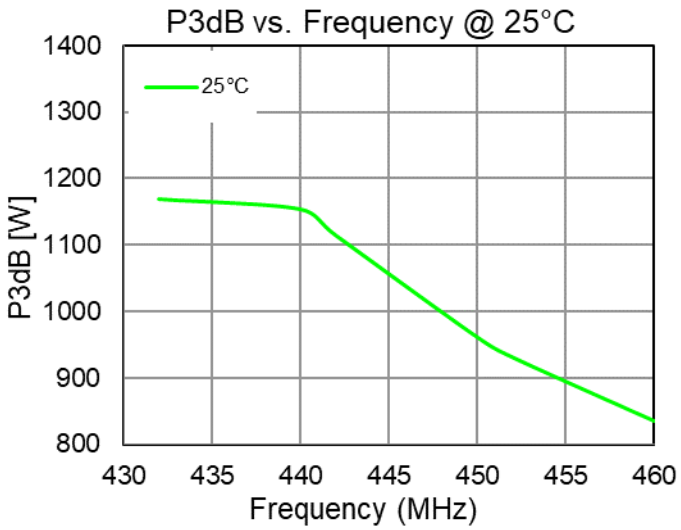


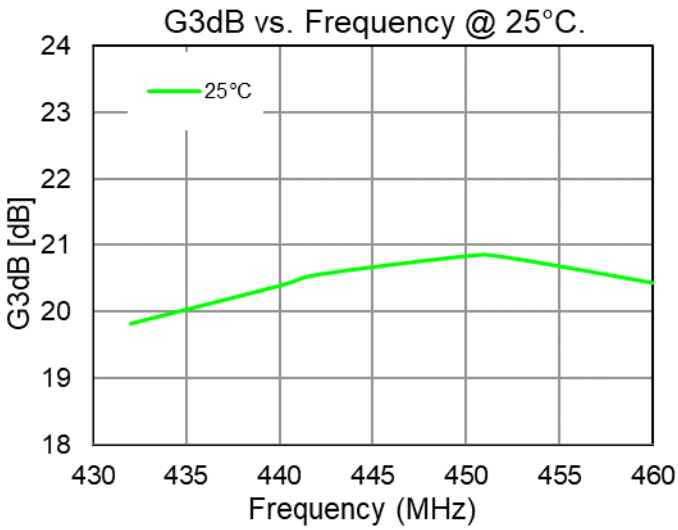


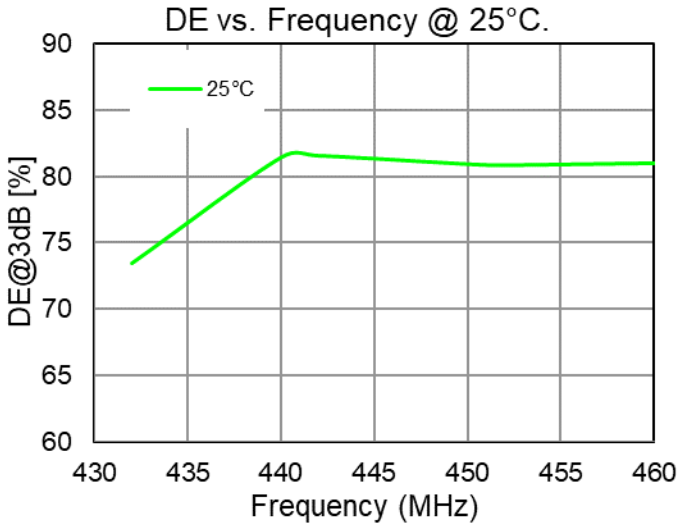


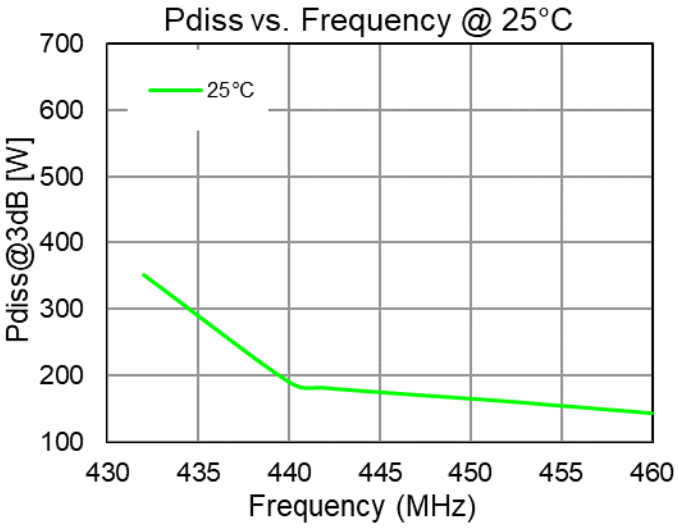
Power Driveup Performance at 25°C of 432 – 460 MHz EVB [1]

Notes:
1. Test Conditions: V_D = 65 V, I_{DQ} = 1.5 A, 500 us Pulse Width, 5% Duty Cycle.

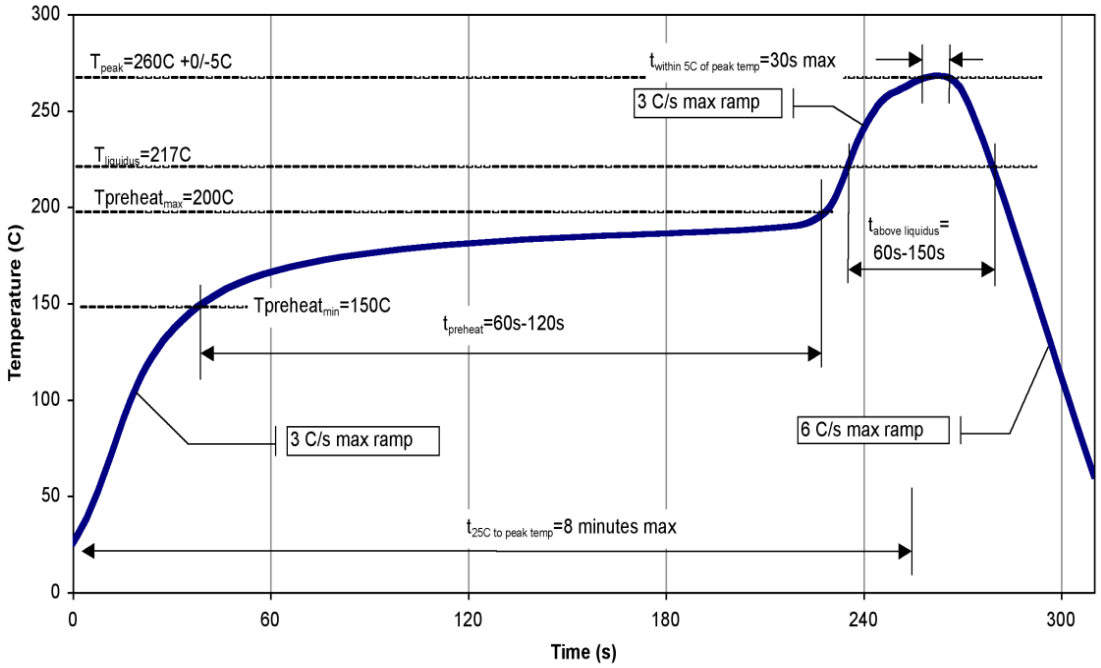








Recommended Solder Temperature Profile



Handling Precautions

Parameter	Rating	Standard
ESD – Human Body Model (HBM)	Class 1A 250V	JEDEC JS-001
ESD – Charged Device Model (CDM)	Class C3 1000V	JEDEC JS-002
MSL – Moisture Sensitivity Level	MSL3	JESD J-STD-020 (260°C Convection reflow)

Caution!
ESD-Sensitive Device

Solderability

Compatible with both lead-free (260°C max. reflow temp.) and tin/lead (245°C max. reflow temp.) soldering processes.
Solder profiles available upon request.

Contact plating: NiAu. Au thickness is 100micro-inches minimum.

RoHS Compliance

This part is compliant with 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment) as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A ($C_{15}H_{12}Br_4O_2$) Free
- PFOS Free
- SVHC Free

Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about Qorvo:

Web: www.qorvo.com Tel: +1.844.890.8163
Email: info-sales@qorvo.com

For technical questions and application information: Email: info-products@qorvo.com

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